Search Notes			
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Application/Control No.	Applicant(s)/Patent und Reexamination	er
09/842,025	BU ET AL.	
Examiner	Art Unit	
Hai V Nguyen	2142	

SEARCHED				
Class	Subclass	Date	Examiner	
709	224	1/23/2006	HN	
713	201	1/23/2006	HN	
707	3, 205	1/23/2006	HN	
713	155	1/23/2006	HN	
370	328	1/23/2006	HN	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Search Updated	1/23/2006	ни